

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination AWEYA ET AL.
	Examiner Majid A Banankhah	Art Unit 2127

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,744,767	06-2004	Chiu et al.	370/395.21
	B	US-6,675,220	01-2004	Bergamasco et al.	709/232
	C	US-6,333,917	12-2001	Lyon et al.	370/236
	D	US-6,717,912	04-2004	Lemyre et al.	370/230
	E	US-6,324,165	11-2001	Fan et al.	370/232
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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